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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/810,510	03/26/2004	Fan Ho	24295/81401	1180
37803 SIDLEY AUST	7590 12/17/2007		EXAMINER	
555 CALIFOR			ANDUJAR, LEONARDO ART UNIT PAPER NUMBER	
SUITE 2000 SAN FRANCIS	SCO, CA 94104-1715		ART UNIT PAPER NUMBER	
om Hamen	500, 0117 1101 1713		2826	
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			12/17/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)				
	10/810,510	HO, FAN				
Office Action Summary	Examiner	Art Unit				
	Leonardo Andújar	2826				
The MAILING DATE of this communication ap						
Period for Reply						
A SHORTENED STATUTORY PERIOD FOR REPL WHICHEVER IS LONGER, FROM THE MAILING D - Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period - Failure to reply within the set or extended period for reply will, by statut Any reply received by the Office later than three months after the mailin earned patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNIC. 136(a). In no event, however, may a rep will apply and will expire SIX (6) MONT. e, cause the application to become ABA	ATION. lly be timely filed HS from the mailing date of this communication NDONED (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on 10/0	<u>11/2007</u> .					
•	• • • • • • • • • • • • • • • • • • •					
·	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
closed in accordance with the practice under	Ex paπe Quayle, 1935 C.D.	11, 453 O.G. 213.				
Disposition of Claims						
4)⊠ Claim(s) <u>1-31</u> is/are pending in the application	1.					
4a) Of the above claim(s) <u>21-31</u> is/are withdra	wn from consideration.					
5) Claim(s) is/are allowed.						
6)⊠ Claim(s) <u>1-20</u> is/are rejected.						
7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/o	or election requirement					
o) Claim(s) are subject to restriction and the	or election requirement.					
Application Papers						
9) The specification is objected to by the Examine	er.		•			
10) The drawing(s) filed on is/are: a) acc						
Applicant may not request that any objection to the	• • • • • • • • • • • • • • • • • • • •	•	<i>(</i> .1)			
Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the E			(a).			
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreigr a) All b) Some * c) None of:	n priority under 35 U.S.C. §	I 19(a)-(d) or (f).				
 Certified copies of the priority documen 	ts have been received.					
2. Certified copies of the priority documen	·	·				
3. Copies of the certified copies of the price	•	eceived in this National Stage				
application from the International Burea * See the attached detailed Office action for a list		eceived				
	tor the continue copies her is					
Attachment(s)						
1) Notice of References Cited (PTO-892)		mmary (PTO-413)				
 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date 		Mail Date prmal Patent Application (PTO-152)				

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DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 10/01/2007 has been entered.

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1-12 and 14-20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kledzik (US 5,266,912) in view of Wenzel et al (US 5,635,767).
- 4. Regarding claim 1, Kledzik (e.g. figs. 1-3) A multi-chip module (MCM) comprising: a first integrated circuit (IC) chip 13 on a substrate 17/51; a first ground plane 33 coupled to the first IC chip; a second IC chip 17 on the substrate17/52; and a second ground plane 21/33 coupled to the second IC chip. Kledzik does not disclose that the first ground plane is physically separated and electrically isolated from the second ground plane. However, Wenzel discloses that a first and seocond ground planes physically and electrically separated (claim 9). It would have been obvious to

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one having ordinary skills in the art at the time of the invention to isolate the first and second planes of Kledzik as suggested by Wenzel to avoid noise and cross coupling.

- 5. Regarding claim 2, Kledzik shows that the first and second ground planes is coupled to at least one external lead 27 of the MCM.
- 6. Regarding claim 3, Kledzik shows that the at the first and second ground planes is is formed as respective trace on the substrate.
- 7. Regarding claim 4, Kledzik shows that the at the first and second ground planes is substantially rigid (col. 2/lls. 36-59). Note that substrate retains it shape at normal condition.
- 8. Regarding claim 5, Kledzik shows that the at the first and second ground planes is substantially flexible (col. 2/lls. 36-59). Note that the layer comprises a cu layers formed on a polyimide layer. This type of structure can be considered flexible since both of the layers exhibit some degree of flexibility.
- 9. Regarding claim 6, Kledzik shows that the first and second planes are comprise a strip of conductive material (col. 2/lls. 36-59).
- 10. Regarding claim 7, Kledzik shows that the first and second planes are comprise a layer of conductive material (col. 2/lls. 36-59).
- 11. Regarding claim 8, Kledzik shows that the first and second planes comprise a substantially solid layer of conductive material (col. 2/lls. 36-59).
- 12. Regarding claim 9, Kledzik teaches that the first and second ground planes comprise a grid of conductive material. Note that the ground plane is part of a ping grid array.

13. Regarding claims 10 and 11, Kledzik shows that the first chip is bonded/attached to the first ground plane, and the second chip is bonded/attached to the second ground plane. Note that the chips are connected to the upper layers that are bonded/attached to the ground planes.

- 14. Regarding claims 12 and 14, Kledzik shows that the first and second chips comprise DRAMS (col. 1/lls. 15-27).
- 15. Regarding claim 15, Kledzik shows that the first and second chips are application specific integrated circuits (e.g. ROM, SRAM, DRAM; col. 1/lls. 15-27).
- 16. Regarding claim 16, Kledzik shows one of the first and second chips is coupled to a plurality of input/output connectors 27 of the MCM and the other of the first and second chips is not coupled to any input/output connectors of the MCM. In this case, the chips of the package 53 can be recognized as the second chip.
- 17. Regarding claim 17, Kledzik shows that the first chip is coped to the second chip via at least one trace 43.
- 18. Regarding claims 18 and 19, Kledzik shows that at least one of the first and second chips may be tested without affecting operation of the other of the first and second chips in the MCM. Note that packages are independent units. Therefore, they can be independently tested.
- 19. Regarding claim 20, Kledzik first power plane coupled to the first IC chip; and a second power plane couple to the second IC chip (col. 7/lls. 15-25).
- 20. Claim 13 is rejected under 35 U.S.C. 103(a) as being unpatentable over Kledzik (US 5,266,912) in view of Wenzel et al (US 5,635,767) further in view of Wolf.

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21. Kledzik in view of Wenzel shows most aspects of the instant invention including chips attached to the first and second ground planes. However, Kledzik in view of Wenzel does not disclose that solder balls (flip chip technique) can be used as connection means. Nonetheless, the use of solder balls as connection means is considered an obvious design choice and it is not patentable unless unobvious or unexpected results are obtained from these changes. It appears that these changes produce no functional differences and therefore would have been obvious. Note In re Leshin, 125 USPQ 416. For example, the advantages of flip chip bonding (solder ball or C4) are: 1) the entire chip surface can be covered with solder bumps. In other words, bonding locations are not limited to the chip perimeter, thus more I/O capability is provided than by a perimeter interconnections on a die with the same size, and 2) the very short lengths of the chip to package interconnection paths minimizes their inductance (see Wolf pages 857-8). It would have been obvious to one of ordinary skill in the art at the time the invention was made to use solder balls to make the electrical connections of the device disclosed by Kledzik in view of Wenzel in order to provide more I/O capability and to minimizes the inductance as taught Wolf.

Response to Arguments

22. Applicant's arguments 10/01/2007 have been considered but are most in view of the new ground(s) of rejection.

Conclusion

23. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Leonardo Andújar whose telephone number is 571-272-

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1912. The examiner can normally be reached on Mon through Thu from 9:00 AM to

7:30 PM EST.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Sue Purvis can be reached on 571-272-1236. The fax phone number for

the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the

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Primary Examine

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12/07/2007